

SUBCLASS

116

45/14

(Date)

ORIGINAL

INTERNATIONAL CLASSIFICATION

(Assistant Examiner)

(Legal Instruments Examiner) (Date)

С

CLASS

425

В 2 9

Final

Application/Control No.

**ISSUE CLASSIFICATION** 

129.1

10/797,641

EDMUND H. LEE

Examiner

121

278

CLASS

425

264

Applicant(s)/Patent under Reexamination SAITO, KAZUHIRO

Art Unit

CROSS REFERENCE(S)

SUBCLASS (ONE SUBCLASS PER BLOCK)

1791

**Total Claims Allowed: 4** 

0.G. Print Claim(s) Print Fig. 8

EDMUND H. LEE PRIMARY EXAMINER, 1791 0.G. /EDMUND H. LEE/ 2/22/08 1 (Primary Examiner) (Date)

	Claims renumbered in the same order as presented by applicant												СРА			□ T.D.		🔲 R.1.47	
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3	6	1		36			66			96			126			156			186
	7			37			67			97			127			157			187
	8			38			68			98			128			158			188
	9	1		39			69			99			129			159			189
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